

# APPROVAL SHEET

WLPN505040 Series SMD Shielded Power Inductors

SILVECHNOLOGY CORPC

\*Contents in this sheet are subject to change without prior notice.

ASC \_WLPN505040 Series\_V3.0

Nov. Y2017

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#### Features

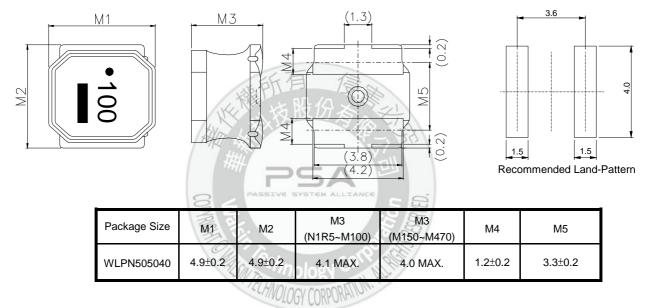
- 1. Close magnetic loop with magnetic resin shielded.
- 2. High inductance.

## **Applications**

- 1. General propose power inductor in DC power system.
- 2. Inductor in DC/DC converter.
- 3. LC filter in Audio D class Amplifier.
- 4. Use in STB 
  Notebook 
  Radio 
  LCDs 
  other electrical devices.

#### **Shape and Dimension**

Unit: mm



## Ordering Information

WL	PN	5050	40	Ν	1R5	L	В
Product Code	Series	Dimensions	Thickness	Tolerance	Value	Packing Code	
WL: Inductor	SMD Shielded Power Inductors	4.9 * 4.9 mm	4.1 mm	M: ± 20% N: ± 30%	1R5 = 1.5uH 150 = 15.0uH	L=13" Reeled (Embossed tape)	B:STD

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## **Electrical Characteristics**

	L (uH)	Inductance Tolerance	Test Freq (KHz)	DCR (Ω) ±20%.	SRF Min. (MHz)	Rated Current (mA)	
WLPN505040 Series						Saturation Current Idc1	Temperature Rise Current Idc2
WLPN505040N1R5LB	1.5	N	100	0.017	60	6400	4500
WLPN505040N2R2LB	2.2	N	100	0.022	42	5000	3700
WLPN505040N3R3LB	3.3	N	100	0.027	32	4000	3300
WLPN505040N4R7LB	4.7	N	100	0.029	28	3300	3100
WLPN505040M6R8LB	6.8	М	100	0.049	21	2800	2400
WLPN505040M100LB	10	М	100	0.056	18	2300	2100
WLPN505040M150LB	15	М	100	0.080	13	2000	1800
WLPN505040M220LB	22	М	100	0.126	9	1500	1400
WLPN505040M330LB	33	М	100	0.180	7	1300	1200
WLPN505040M470LB	47	М	100	0.310	6	1100	900

1. Test Frequency: 100KHz

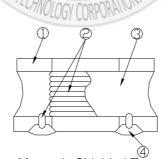
2. Test Equipment:

Inductance: Chroma3302+1320+16502. or equivalent. DCR: Chroma16502 or equivalent. SRF: HP4291B or equivalent.

3. Saturation Current Idc1: The value of current causes a 30% inductance reduction from initial value.

- 4. Temperature rise current ldc2: The value of current causes a 40  $^\circ\!C$  temperature rise.
- 5. Rated Current: Either Idc1 or Idc2 whichever is smaller.
- 6. Operating Temperature Range:-25℃ to +125℃ (Including self-temperature rise)
- 7. Storage Temp. Range :  $-40^{\circ}$ C to  $+85^{\circ}$ C.
- 8. MSL : Level 1

**Structural Drawing:** 



Magnetic Shielded Type

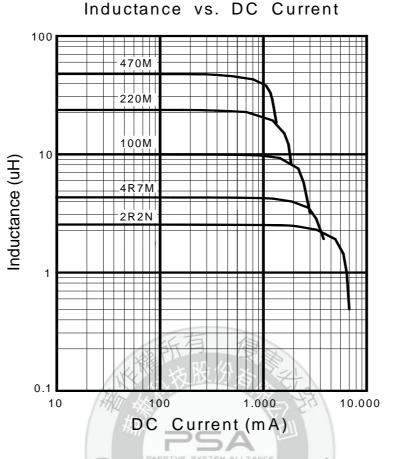
- Ferrite core.
- Ni-Zn ferrite
- ② Winding wire Polyurethane-copper wire
- ③ Over-coating resin.
- ④ Electrode

Epoxy resin, containing ferrite powder External electrode (substrate) Ag External electrode (base plating) Ni-Sn

External electrode (top surface solder coating) Sn-Ag-Cu

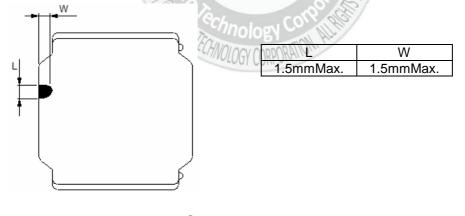


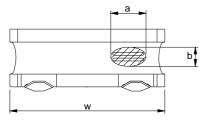
## ELECTRICAL CURVE



## **Core Chipping**

The appearance standard of the chipping size in top side, of bottom side ferrite core is following dimension.

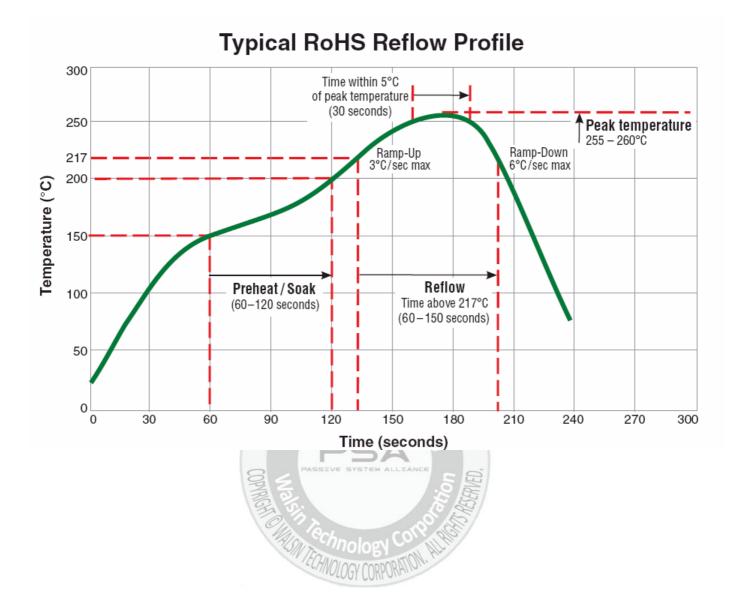




- ① Width direction (dimension a): Acceptable when a<=w/2 Nonconforming when a>w/2
- <sup>(2)</sup> Length direction (dimension b): Dimension b is not specified.
- ③ When total area of exposed wire occurring to each sides is not greater than 50% of coating resin area, that is acceptable.



## TYPICAL RoHS REFLOW PROFILE



Nov. Y2017

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	Test Item	Standard	Test method
	Resistance to Deflection	No damage.	Force Rod 5.1
Ş			R5 Board R5 $45\pm2$ $45\pm2$ $45\pm2$ $45\pm2$ 1.5
RACTERISTIC			Reaches to 2 mm. Land dimensions Test board size :100x40x10 Test board material I: glass epoxy-resin Solder cream thickness:0.1 Unit: mm
MECHANICAL CHARACTERISTICS	Adhesion of Terminal Electrode	Shall not come off PC board	The test samples shall be soldered to the test board By the reflow soldering conditions shown in Table 1. 10  N.5 s
ME		COPPINGE	Applied force:10 N to X and Y directions Duration:5 s. Solder cream thickness:0.1 mm (Refer to recommended Land Pattern Dimensions Defined in "Precaution")
	Body strength	No damage	Applied force :20 N Duration :10 s

#### Mechanical Performance /Environmental Test Performance Specifications: (WLPN505040 series)



Test Item	Standard	Test method				
Resistance to Vibration	△L/L:within±10% No abnormality observed In appearance	The test samples shall be soldered to the test board by The reflow soldering conditions shown in Table 1.Then It shall be submitted to below test conditionsFrequency range10Hz~55HzTotal Amplitude1.5mm(May not exceed acceleration 196 m/S²)Sweeping Method10Hz to 55Hz to 10 Hz for 1 min.TimeFor 2 hours on each X,Y, and Z axis.				
Resistance to Soldering heat (Reflow)	△L/L:within±10% No abnormality observed In appearance	The test sample shall be exposed to reflow oven at 230±5 deg C for 40 seconds, with peak temperature at 260±5 deg C for 5 seconds, 2 times. Test board thickness:1.0 mm Test board material :glass epoxy-resin				
Solder ability At least 90% of surface of terminal electrode is covered by new solder.		The test samples shall be dipped in flux, and thenImmersed in molten solder as shown in below table.Flux: Methanol solution containing rosin 25%Solder Temperature245±deg C				
		Time5±1.0 S.Immersing Speed25 mm/s				
Temperature Characteristics	△L/L:within±20% No abnormality observed In appearance	Measurement of inductance shall be taken at temperature Range within -25 deg C to +85 deg C. With reference to inductance value at +20 deg C, change Rate shall be calculated.				
Thermal shock	△L/L:within±10% No abnormality observed In appearance	The test samples shall be soldered to test board         By the reflow soldering conditions shown in Table 1.         The test samples shall be placed at specified         Shown in below table in sequence.         The temperature cycle shall be repeated 100 cycles.         Conditions of steps for 1 cycle         Step       Temperature         1       -40±3 deg C         2       Room Temp         3       85±2 deg C         3       85±2 deg C         3       maximum         3       85±2 deg C         3       maximum				
Low Temperature life Test	△L/L:within±10% No abnormality observed In appearance	The test samples shall be soldered to the test board by The reflow soldering conditions shown in Table 1.After that, the test samples shall be placed at test Conditions as shown in below table.Temperature-40±2 deg CTime500 +24/-0 h				

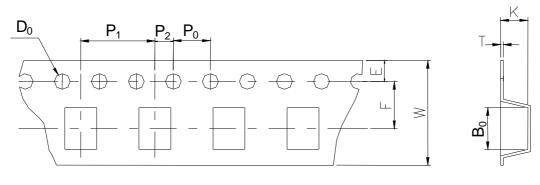


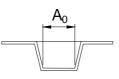
1	Test Item	Standard	Test method			
	Loading at high temperature life test	△L/L:within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specified temperature and applied the rated current continuously as shown in below table.			
			Temperature 85±2 deg C			
			Applied current (Refer to Page 3)			
			Time 500+24/-0 h			
ENVIRONMENT TESTS	Damp heat life test	△L/L:within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specified temperature and humidity as shown in below table.			
IME			Temperature 60±2 deg C			
RON		LAE P	Humidity 90~95%RH			
ENVI		HALL HE REAL	Time 500+24/-0 h			
			The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated curren continuously as shown in below table.			
	Loading under Damp heat life test	△L/L:within±10% No abnormality observed in appearance.	reflow soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated current			
	Damp heat life	No abnormality observed in appearance.	reflow soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated current continuously as shown in below table.			
	Damp heat life	No abnormality observed in appearance.	reflow soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated current continuously as shown in below table.			
	Damp heat life	No abnormality observed	reflow soldering conditions shown in Table 1. The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated current continuously as shown in below table.			



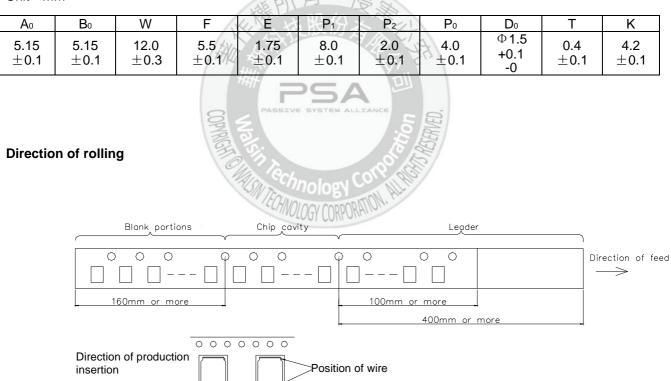
## Tape & Reel Packaging Dimensions:

#### Dimensions



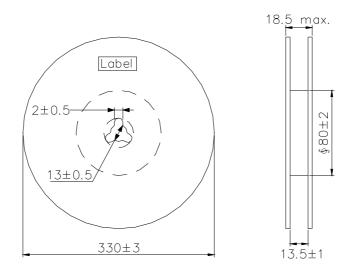


#### Unit : mm





#### Reel



#### Label position: on the opposite side of sprocket holes side of reel

Top tape strength



Quantity per reel : 1.5K pcs

## **Mouser Electronics**

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Walsin:

 WLPN505040M100LB
 WLPN505040N4R7LB
 WLPN505040M150LB
 WLPN505040N3R3LB
 WLPN505040M330LB

 WLPN505040M220LB
 WLPN505040N1R5LB
 WLPN505040N2R2LB
 WLPN505040M470LB
 WLPN505040M6R8LB